Supplementary Information

Structural characterization was carried out by X-ray diffraction analysis using a Panalytical X-Pert Pro diffractometer at Co-K α radiation (K $_{\alpha}$ = 1.79031 Å) equipped with a multichannel detector X'celerator in the θ - θ Bragg-Brentano geometry.



Figure SI 1.a: Refined diffractogram for x= 0. Experimental (red circles), calculated (black line), Difference (Blue line) and Bragg positions (Blue vertical lines). An impurity peak can be observed near 51°.



Figure SI 1.b: Refined diffractogram for x= 0.25. Experimental (red circles), calculated (black line), Difference (Blue line) and Bragg positions (Blue vertical lines).



Figure SI 1.c: Refined diffractogram for x= 0.375. Experimental (red circles), calculated (black line), Difference (Blue line) and Bragg positions (Blue vertical lines).



Figure SI 1.d: Refined diffractogram for x= 0.5. Experimental (red circles), calculated (black line), Difference (Blue line) and Bragg positions (Blue vertical lines).



Figure SI 1.e: Refined diffractogram for x= 0.75. Experimental (red circles), calculated (black line), Difference (Blue line) and Bragg positions (Blue vertical lines).